

Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/812,875	CHOU ET AL.
	Examiner	Art Unit
	Hai L. Nguyen	2816

ISSUE CLASSIFICATION				
ORIGINAL		CROSS REFERENCE(S)		
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)	
331	25	327	3	12
INTERNATIONAL CLASSIFICATION				
H	0	3	D	13/00
			/	
			/	
			/	
			/	

Hai L. Nguyen <i>Anneke Smith</i> (Assistant Examiner) (Legal Instruments Examiner)	3/17/2006 4/3/06 (Date) (Date)	TIMOTHY P. CALLAHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Primary Examiner) <i>BP</i> (Date)	Total Claims Allowed: 11 O.G. Print Claim(s) 1	O.G. Print Fig. 7
--	---	---	---	-------------------------

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	1		31		91		121
2	2		32		92		122
3			33		93		123
4			34		94		124
5	5		35		95		125
6	6		36		96		126
7	7		37		97		127
3	8		38		98		128
9			39		99		129
10			40		100		130
11			41		101		131
12			42		102		132
13			43		103		133
7	14		44		104		134
10	15		45		105		135
11	16		46		106		136
8	17		47		107		137
9	18		48		108		138
19			49		109		139
20			50		110		140
21			51		111		141
22			52		112		142
23			53		113		143
24			54		114		144
25			55		115		145
26			56		116		146
27			57		117		147
28			58		118		148
29			59		119		149
30			60		120		150